



LIST OF PUBLICATIONS CITED BY APPLICANT	Atty Docket No. 0553-0376		Serial No. 10/633, 964			
	Applicant Kazutaka INUKAI					
	Filing Date August 4, 2003		Group			
U. S. PATENT DOCUMENTS						
*EXAMINER INITIAL	DOCUMENT NUMBER	DATE	NAME	CLASS	SUB-CLASS	FILING DATE
FOREIGN PATENT DOCUMENTS						
	DOCUMENT NUMBER	DATE	NAME	English Abstract	English Trans.	FILING DATE
J.L.	JP 2002-278478	09/27/02	Semiconductor Energy Lab Co. Ltd.	X		12/17/01
OTHER PRIOR ART - NON PATENT LITERATURE DOCUMENTS (Include name of author (in CAPITAL LETTERS), title of article or item (book, magazine, journal, serial, symposium, catalog, etc.) date, pages(s), volume-issue number(s), publisher, city and/or country where published).						
EXAMINER:	<i>Jean S</i> — — —			DATE CONSIDERED: 1-24-06		
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LIST OF PUBLICATIONS CITED BY APPLICANT	<u>Atty Docket No.</u> 0553-0376	<u>Serial No.</u> Not Assigned
	<u>Applicant</u> Kazutaka INUKAI	
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U.S. PATENT DOCUMENTS

*EXAMINER INITIAL	DOCUMENT NUMBER	DATE	NAME	CLASS	SUB- CLASS	FILING DATE
	US 2002/ 0153844 A1	10/24/02	Koyama	315	169.3	03/11/02

FOREIGN PATENT DOCUMENTS

	DOCUMENT NUMBER	DATE	NAME	English Abstract	English Trans.	FILING DATE
J.L.	JP 11-102172	04/13/99	Sharp Corp.	X		09/26/97
	EP 1 063 630	12/27/00	Semiconductor			06/23/00
	A2		Energy Lab Co. Ltd.			
	JP 2001-005426	01/12/01	Semiconductor	X		06/23/99
	JP 2001-034237	02/09/01	Energy Lab Co. Ltd.			
	JP 2002-196721	07/12/02	Fujitsu Ltd.	X		07/21/99
	JP 2002-214645	07/31/02	Sony Corp.	X		12/25/00
	JP 2003-087562	03/20/03	Matsushita Electric	X		01/22/01
			Ind Co., Ltd.			
			Toshiba Corp.	X		09/13/01

OTHER PRIOR ART - NON PATENT LITERATURE DOCUMENTS

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EXAMINER:	DATE CONSIDERED:
<i>Dean</i>	<i>1-26-2005</i>

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